# **Power MOSFET**

# 100 V, 30 m $\Omega$ , 28 A, Single N-Channel

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6B75NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	$V_{DSS}$	100	V		
Gate-to-Source Voltage	Э		$V_{GS}$	±16	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	28	Α
Current R <sub>θJC</sub> (Notes 1, 2, 3)	Steady	T <sub>C</sub> = 100°C		19.7	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	56	W
R <sub>θJC</sub> (Notes 1, 2)		T <sub>C</sub> = 100°C		28	
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	7.0	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		5.0	
Power Dissipation	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.5	W
R <sub>θJA</sub> (Notes 1 & 2)		T <sub>A</sub> = 100°C		1.75	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	141	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to + 175	°C
Source Current (Body Diode)			I <sub>S</sub>	43	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 1.7 A)			E <sub>AS</sub>	177	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	43	

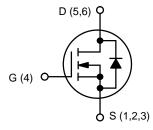
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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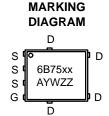
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	30 mΩ @ 10 V	00.4
	46 mΩ @ 4.5 V	28 A



**N-CHANNEL MOSFET** 



DFN5 (SO-8FL) CASE 488AA STYLE 1



6B75NL = NVMFS6B75NL 6B75LW = NVMFS6B75NLWF A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

OFF CHARACTERISTICS         Drain-to-Source Breakdown Voltage         V(BR)DSS         VGS = 0 V. ID = 250 μA         100         62           Drain-to-Source Breakdown Voltage Emperature Coefficient Zero Gate Voltage Drain Current         V(BR)DSS/IDS         VGS = 0 V. ID = 250 μA         100         10	Unit	Max	Тур	Min	Test Condition		Symbol	Parameter
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$								OFF CHARACTERISTICS
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V			100	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	mV/°C		62				V <sub>(BR)DSS</sub> / T <sub>J</sub>	
Gate—to–Source Leakage Current         I $_{GSS}$ V $_{DS} = 0 \text{ V}$ , V $_{GS} = 16 \text{ V}$ 100           ON CHARACTERISTICS (Note 4)         VOS = 16 V         100           Gate Threshold Voltage         VGS(TH)         VGS = VDS, ID = 250 μA         1.0         3.0           Threshold Temperature Coefficient         VGS(TH)/TJ         -5.3         -5.3         -5.3           Drain—to–Source On Resistance         RDS(on)         VGS = 10 V         ID = 10 A         35         46           CHARGES, CAPACITANCES & GATE RESISTANCE           Input Capacitance         CISS         VGS = 4.5 V         740	٨	10			$T_J = 25^{\circ}C$	$V_{GS} = 0 V,$	I <sub>DSS</sub>	Zero Gate Voltage Drain Current
ON CHARACTERISTICS (Note 4)           Gate Threshold Voltage         V <sub>GS(TH)</sub> V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA         1.0         3.0           Threshold Temperature Coefficient         V <sub>GS</sub> (TH)/T <sub>J</sub> -5.3         -5.3           Drain-to-Source On Resistance         R <sub>DS(on)</sub> V <sub>GS</sub> = 10 V V <sub>GS</sub> = 10 V V <sub>GS</sub> = 4.5 V         24.7         30           CHARGES, CAPACITANCES & GATE RESISTANCE           Input Capacitance         C <sub>ISS</sub> V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V         260         -6.0           Reverse Transfer Capacitance         C <sub>RSS</sub> V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 25 A         5.4         -6.0           Total Gate Charge         Q <sub>G(TOT)</sub> V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 25 A         5.4         -6.0           Threshold Gate Charge         Q <sub>G</sub> (TH)         V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 25 A         5.4         -6.0           Gate-to-Source Charge         Q <sub>G</sub> V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 25 A         3.2         -6.0           Gate-to-Drain Charge         Q <sub>G</sub> V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 25 A         3.2         -7.0           SWITCHING CHARACTERISTICS (Note 5)         V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V, V <sub>DS</sub> = 50 V, I <sub>D</sub> = 25 A, R <sub>G</sub> = 2.5 Ω         9.1         -7.5           Turn-Off Delay Time         t <sub>I</sub> V <sub>GS</sub> = 2	μΑ	250			T <sub>J</sub> = 125°C	V <sub>DS</sub> = 80 V		
	nA	100			= 16 V	$V_{DS} = 0 V, V_{GS}$	I <sub>GSS</sub>	Gate-to-Source Leakage Current
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$								ON CHARACTERISTICS (Note 4)
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V	3.0		1.0	: 250 μA	$V_{GS} = V_{DS}, I_D =$	V <sub>GS(TH)</sub>	Gate Threshold Voltage
$ \begin{array}{ c c c c c c c c } \hline Drain-to-Source On Resistance & R_{DS(on)} & V_{GS} = 4.5 \ V & I_D = 10 \ A & 35 & 46 \\ \hline \hline CHARGES, CAPACITANCES & GATE RESISTANCE \\ \hline Input Capacitance & C_{ISS} & & 740 & \\ \hline Output Capacitance & C_{OSS} & V_{GS} = 0 \ V, f = 1 \ MHz, \ V_{DS} = 25 \ V & 260 & \\ \hline Reverse Transfer Capacitance & C_{RSS} & & 20 & \\ \hline Total Gate Charge & Q_{G(TOT)} & & & 11.3 & \\ \hline Threshold Gate Charge & Q_{GS} & V_{GS} = 4.5 \ V, V_{DS} = 50 \ V; \ I_D = 25 \ A & 5.4 & \\ \hline Gate-to-Drain Charge & Q_{GS} & V_{GS} = 10 \ V, V_{DS} = 50 \ V; \ I_D = 25 \ A & 3.2 & \\ \hline SWITCHING CHARACTERISTICS (Note 5) & & & 3.8 & \\ \hline Turn-Off Delay Time & t_{d(OFF)} & V_{GS} = 4.5 \ V, V_{DS} = 50 \ V, \ I_D = 25 \ A, R_G = 2.5 \ \Omega & 16 & \\ \hline DRAIN-SOURCE DIODE CHARACTERISTICS \\ \hline Forward Diode Voltage & V_{SD} & V_{GS} = 0 \ V, \ I_S = 20 \ A & T_J = 25^{\circ}C & 0.94 & 1.2 \\ \hline T_J = 125^{\circ}C & 0.84 & \\ \hline \end{array}$	mV/°C		-5.3				V <sub>GS(TH)</sub> /T <sub>J</sub>	Threshold Temperature Coefficient
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		30	24.7			V <sub>GS</sub> = 10 V		
Input Capacitance   Class   Output Capacitance   Class   Output Capacitance   Class   VgS = 0 V, f = 1 MHz, VDS = 25 V   260	mΩ	46	35		I <sub>D</sub> = 10 A	V <sub>GS</sub> = 4.5 V	R <sub>DS(on)</sub>	Drain-to-Source On Resistance
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$							TANCE	CHARGES, CAPACITANCES & GATE RESIS
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			740				C <sub>ISS</sub>	Input Capacitance
	pF		260		V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V		C <sub>OSS</sub>	Output Capacitance
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			20				C <sub>RSS</sub>	Reverse Transfer Capacitance
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	nC		5.4				_	
			11.3				$Q_{G(TOT)}$	Total Gate Charge
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			1.6				Q <sub>G(TH)</sub>	Threshold Gate Charge
Plateau Voltage $V_{GP}$ 3.8    SWITCHING CHARACTERISTICS (Note 5)  Turn-On Delay Time $t_{d(ON)}$ 9.1    Rise Time $t_r$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 50 \text{ V}, I_D = 25 \text{ A}, R_G = 2.5 \Omega}$ 16    Fall Time $t_f$ 71.5    DRAIN-SOURCE DIODE CHARACTERISTICS  Forward Diode Voltage $V_{SD}$ $V_{GS} = 0 \text{ V}, I_S = 20 \text{ A}$ $T_J = 25^{\circ}\text{C}$ 0.94 1.2 $T_J = 125^{\circ}\text{C}$ 0.84			3.2				Q <sub>GS</sub>	Gate-to-Source Charge
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			1.5				$Q_{GD}$	Gate-to-Drain Charge
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V		3.8				$V_{GP}$	Plateau Voltage
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$					<u>_</u>			SWITCHING CHARACTERISTICS (Note 5)
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			9.1				t <sub>d(ON)</sub>	Turn-On Delay Time
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	ns ns		88.3		s = 50 V	Vcs = 4.5 V. Vns	t <sub>r</sub>	Rise Time
			16		$V_{GS} = 4.3 \text{ V}, V_{DS} = 30 \text{ V},$ $I_{D} = 25 \text{ A}, R_{G} = 2.5 \Omega$		t <sub>d(OFF)</sub>	Turn-Off Delay Time
Forward Diode Voltage $V_{SD}$ $V_{GS} = 0 \text{ V}, \\ I_{S} = 20 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ 0.94 1.2 $T_{J} = 125^{\circ}\text{C}$ 0.84			71.5					Fall Time
$I_{S} = 20 \text{ A}$ $I_{J} = 125^{\circ}\text{C}$ 0.84							s	DRAIN-SOURCE DIODE CHARACTERISTIC
$I_S = 20 \text{ A}$ $T_J = 125^{\circ}\text{C}$ 0.84		1.2	0.94		T <sub>J</sub> = 25°C	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A	$V_{SD}$	Forward Diode Voltage
Reverse Recovery Time t <sub>RR</sub> 38.4	V		0.84		T <sub>J</sub> = 125°C			
, INA			38.4		V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 25 A		t <sub>RR</sub>	Reverse Recovery Time
Charge Time	ns		22.6					Charge Time
			15.8					Discharge Time
Reverse Recovery Charge Q <sub>RR</sub> 40	nC		40					Reverse Recovery Charge

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

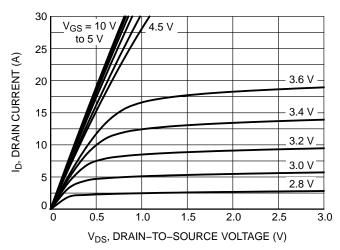


Figure 1. On-Region Characteristics

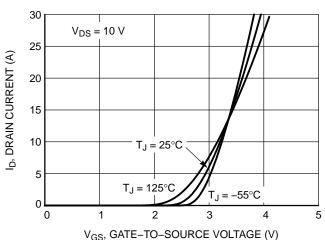


Figure 2. Transfer Characteristics

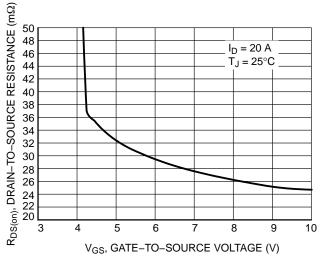


Figure 3. On–Resistance vs. Gate–to–Source Voltage

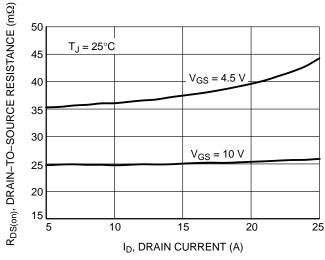


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

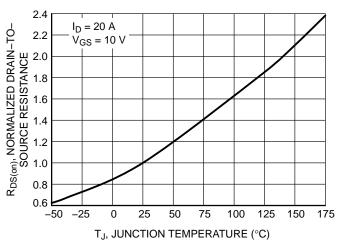


Figure 5. On–Resistance Variation with Temperature

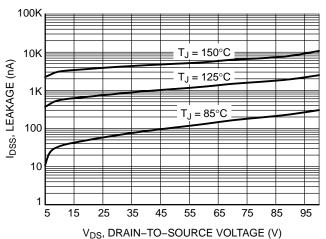
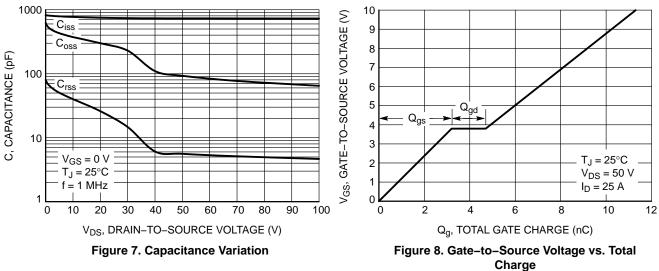


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**



Charge

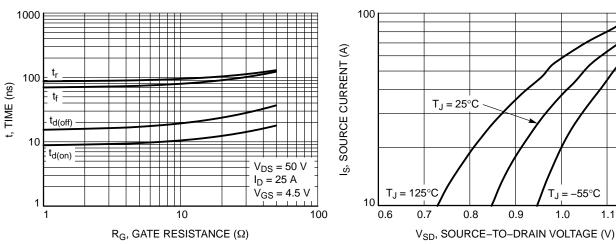


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

1.2

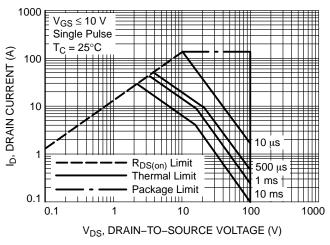


Figure 11. Maximum Rated Forward Biased Safe Operating Area

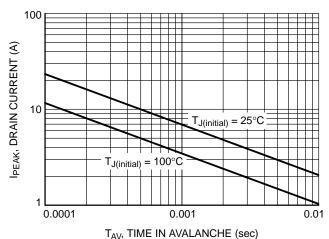


Figure 12. IPEAK vs. TAV

#### **TYPICAL CHARACTERISTICS**

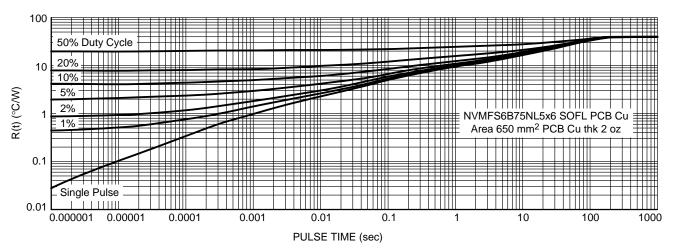


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFS6B75NLT1G	6B75NL	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS6B75NLWFT1G	6B75LW	DFN5 (Pb–Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS6B75NLT3G	6B75NL	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS6B75NLWFT3G	6B75LW	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC				
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
θ	0 °		12 °			

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

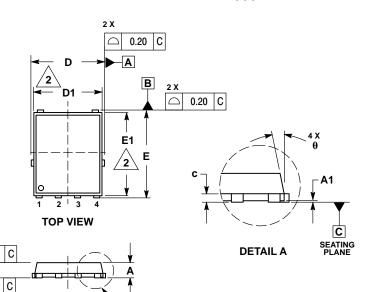
= Assembly Location Α

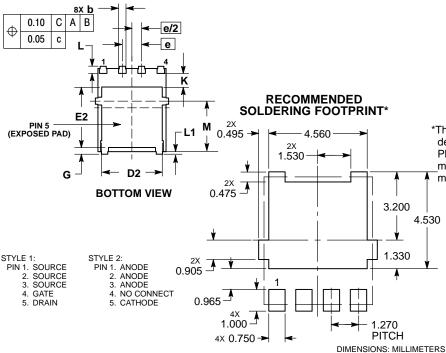
= Lot Traceability

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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